

## EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L2	525	(difference contrast disagreement discrepancy disparateness disparity dissimilarity distinction distinctiveness distinctness diverseness diversity unlikeness deviance divergence change modification variation conflict discord discordance dissension dissent dissidence disunity friction strife variability variance incompatibility incongruity incongruousness disproportion) with (test\$3 near4 fixture)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L3	422	L2 and ((measur\$3 gaug\$3 calculat\$3 comput\$7 figur\$3 estimat\$3 judg\$3 tall\$3 test\$3 examin\$5 inspect\$3 check\$3 observ\$3 analyz\$3 investigat \$3 diagno\$5) with (DUT device or circuit chip memory))	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L4	2	L3 and ((test\$3 or interface) with hardware with calibrat\$3)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L5	373	test\$3 with hardware with calibrat\$3	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L6	2	L5 and L2	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L7	373	L5 and (@pd< "200040601" or @ad< "200040601" or @prad< "200040601" or @rlad< "200040601")	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L8	2	L7 and L2	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L9	345	L7 and ((measur\$3 gaug\$3 calculat\$3 comput\$7 figur\$3 estimat\$3 judg\$3 tall\$3 test\$3 examin\$5 inspect\$3 check\$3 observ\$3 analyz\$3 investigat \$3 diagno\$5) with (DUT device or circuit chip memory))	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44

L10	666	(difference contrast disagreement discrepancy disparateness disparity dissimilarity distinction distinctiveness distinctness diverseness diversity unlikeness deviance divergence change modification variation conflict discord discordance dissension dissent dissidence disunity friction strife variability variance incompatibility incongruity incongruousness disproportion) with (test\$3 with fixture)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L11	18681	(difference contrast disagreement discrepancy disparateness disparity dissimilarity distinction distinctiveness distinctness diverseness diversity unlikeness deviance divergence change modification variation conflict discord discordance dissension dissent dissidence disunity friction strife variability variance incompatibility incongruity incongruousness disproportion) with (reference and production)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L12	1	L9 and L11	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L13	2	(difference contrast disagreement discrepancy disparateness disparity dissimilarity distinction distinctiveness distinctness diverseness diversity unlikeness deviance divergence change modification variation conflict discord discordance dissension dissent dissidence disunity friction strife variability variance incompatibility incongruity incongruousness disproportion) with ((reference and production) with fixture)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44

L14	2	L7 and ((measur\$3 gaug\$3 calculat\$3 comput\$7 figur\$3 estimat\$3 judg\$3 tall\$3 test\$3 examin\$5 inspect\$3 check\$3 observ\$3 analyz\$3 investigat\$3 diagno\$5) with ((DUT device or circuit chip memory) with (plurality or many or different) with (test\$3 near7 fixture)))	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L15	3	L7 and ((measur\$3 gaug\$3 calculat\$3 comput\$7 figur\$3 estimat\$3 judg\$3 tall\$3 test\$3 examin\$5 inspect\$3 check\$3 observ\$3 analyz\$3 investigat\$3 diagno\$5) with ((DUT device or circuit chip memory) with (plurality or many or different multiple) with (test\$3 near7 fixture)))	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L17	237	L9 and ((error or different near7 array or (difference with between with test\$3 near7 fixture\$1)))	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L18	145	L17 and (port or pin)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L19	36854	(difference contrast disagreement discrepancy disparateness disparity dissimilarity distinction distinctiveness distinctness diverseness diversity unlikeness deviance divergence change modification variation conflict discord discordance dissension dissent dissidence disunity friction strife variability variance incompatibility incongruity incongruousness disproportion) with ((test\$3 with fixture) or (connector or null near3 fixture))	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L20	428	test\$3 with hardware with (calibrat\$3 or transformat\$3)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L21	4	L20 and L19	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44

L22	8	L20 and ((two near3 different near3 fixture) ((plurality or many or multiple) with fixture) ((reference or product\$3 near7 fixture))	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L23	373	test\$3 with hardware with calibrat\$3	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L24	373	L23 and (@pd<"200040601" or @ad<"200040601" or @prad<"200040601" or @rlad<"200040601")	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L25	345	L24 and ((measur\$3 gaug\$3 calculat\$3 comput\$7 figur\$3 estimat\$3 judg\$3 tall\$3 test\$3 examin\$5 inspect\$3 check\$3 observ\$3 analyz\$3 investigat\$3 diagno\$5) with (DUT device or circuit chip memory))	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L26	224	L25 and (tester or test\$3 near4 (equipment or system))	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L27	184	L26 and (error fault or failure default deficienc\$1 malfunction \$3)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L28	35	L27 and ((connect\$3 or interfac\$3 coupl\$3 join\$4 combin\$4) with (DUT or device or circuit) with (tester test\$3 near (system or equipment)))	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L29	35	L27 and (( test near fixture connect\$3 or interfac\$3 coupl\$3 join\$4 combin\$4) with (DUT or device or circuit) with (tester test\$3 near(system or equipment)))	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L30	263	((test\$3 or diagnos\$4 or calibrat\$3 or configur\$5 or examin\$5 or check\$3 or verif\$7 prob\$3 inspect\$3 measur\$3 gaug\$3 calculat\$3 comput\$7 figur\$3 estimat\$3 judg\$3 tall\$3 observ\$3 analyz\$3 investigat\$3) with (DUT device or circuit chip memory) with (different disparat\$3 dissimilar distinct\$3 distinguishable diverse other unlike unlike unequal disproportion\$3 individual non\$1 near analogous non\$1 near alike) near6 (test\$3 near4 fixture\$1)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44

L31	222	L30 and (tester or test\$3 near4 (equipment or system))	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L32	222	L31 and (@pd<"200040601" or @ad<"200040601" or @prad<"200040601" or @rlad<"200040601")	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L33	0	L32 and L23	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L34	22	L32 and (test\$3 with calibrat \$3)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L39	30	(dunsmore near joel).in.	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44
L40	21	L39 and (@pd<"20030611" or @ad<"20030611" or @prad<"20030611" or @rlad<"20030611")	US-PGPUB; USPAT; IBM_TDB	OR	ON	2008/09/16 09:44

9/ 16/ 2008 11:38:51 AM

C:\Documents and Settings\gmerant\My Documents\EAST\Workspaces\10\_537\_031.wsp